Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/792,027	TESSIER ET AL.		
Examiner	Art Unit		
Chen-Wen Jiang	3744		

SEARCHED					
Class	Subclass	Date	Examiner		
62	51				
	94				
	47				
702	57 60				
	61 62				
-	182 186				
	189				
700	286				
	291	9/21/2006	Cl		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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